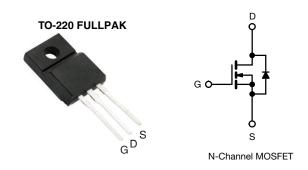


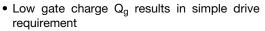


Power MOSFET



PRODUCT SUMMARY				
V _{DS} (V)	500			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V 0.52			
Q _g (Max.) (nC)	52			
Q _{gs} (nC)	13			
Q _{gd} (nC)	18			
Configuration	Single			

FEATURES





- Improved gate, avalanche and dynamic dV/dt ruggedness
- Fully characterized capacitance and avalanche voltage and current
- Effective Coss specified
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

APPLICATIONS

- Switch mode power supply (SMPS)
- Uninterruptible power supply
- High speed power switching
- High voltage isolation = 2.5 kV_{RMS} (t = 60 s, f = 60 Hz)

TYPICAL SMPS TOPOLOGIES

- · Two transistor forward
- · Half and full bridge convertors
- · Power factor correction boost

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRFIB7N50APbF

ABSOLUTE MAXIMUM RATINGS T_C =	= 25 °C, unle	ess otherwis	e noted		
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-source voltage			V _{DS}	500	V
Gate-source voltage			V_{GS}	± 30	7 °
Continuous drain current f	\/ at 10.\/	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$		6.6	
Continuous drain current	V _{GS} at 10 V	T _C = 100 °C	Ι _D	4.2	Α
Pulsed drain current a, e			I _{DM}	44	
Linear derating factor				0.48	W/°C
Single pulse avalanche energy b, e			E _{AS}	275	mJ
Repetitive avalanche current a, e			I _{AR}	11	Α
Repetitive avalanche energy ^a			E _{AR}	6.0	mJ
Maximum power dissipation $T_C = 25 ^{\circ}C$			P _D	60	W
Peak diode recovery dV/dt c, e			dV/dt	6.9	V/ns
Operating junction and storage temperature range			T _J , T _{stg}	-55 to +150	- °C
Soldering recommendations (peak temperature) ^d	For	10 s		300	7
Mounting torque	M3 s	screw		0.6	Nm

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Starting T_J = 25 °C, L = 4.5 mH, R_G = 25 Ω , I_{AS} = 11 A (see fig. 12)
- c. $I_{SD} \le 11$ A, $dI/dt \le 140$ A/µs, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C
- d. 1.6 mm from case
- e. Uses IRFB11N50A, SiHFB11N50A data and test conditions
- f. Drain current limited by maximum junction temperature



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THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum junction-to-ambient	R _{thJA}	-	65	°C/W
Maximum junction-to-case (drain)	R _{thJC}	-	2.1	C/VV

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static		•					
Drain-ssource breakdown voltage	V_{DS}	V _{GS}	= 0 V, I _D = 250 μA	500	-	-	V
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = 1 mA ^d		-	610	-	mV/°C
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		2.0	-	4.0	V
Gate-source leakage	I _{GSS}		V _{GS} = ± 30 V	-	-	± 100	nA
Zero gate voltage drain current	1	V _{DS} =	= 500 V, V _{GS} = 0 V	1	-	25	
Zero gate voltage drain current	I _{DSS}	V _{DS} = 400 V, V _{GS} = 0 V, T _J = 125 °C		1	-	250	μA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} = 10 V	$I_D = 4.0 \text{ A}^b$	-	-	0.52	Ω
Forward transconductance	9 _{fs}	V _{DS} :	= 50 V, I _D = 6.6 A ^d	6.1	-	-	S
Dynamic							
Input capacitance	C_{iss}		$V_{GS} = 0 V$,	ı	1423	-	
Output capacitance	Coss		$V_{DS} = 25 \text{ V},$	1	208	-	
Reverse transfer capacitance	C_{rss}	t = 1.	0 MHz, see fig. 5 ^d	ı	8.1	-	nE
Output capacitance	C		$V_{DS} = 1.0 \text{ V}, f = 1.0 \text{ MHz}$	ı	2000	-	pF
Output capacitance	C _{oss}	$V_{GS} = 0 V$	$V_{DS} = 400 \text{ V}, f = 1.0 \text{ MHz}$	ı	55	-	
Effective output capacitance	Coss eff.		$V_{DS} = 0 V \text{ to } 400 V^{c, d}$	1	97	-	
Total gate charge	Q_g			-	-	52	
Gate-source charge	Q _{gs}	V _{GS} = 10 V	$I_D = 11 \text{ A}, V_{DS} = 400 \text{ V}$ see fig. 6 and 13 b, d	-	-	13	nC
Gate-drain charge	Q_{gd}			-	-	18	1
Turn-on delay time	t _{d(on)}			-	14	-	
Rise time	t _r		= 250 V, I _D = 11 A 9.1 Ω, R _D = 22 Ω,	-	35	-	
Turn-off delay time	t _{d(off)}		see fig. 10 ^{b, d}	-	32	-	ns
Fall time	t _f			-	28	-	
Drain-Source Body Diode Characteristic	cs	•					
Continuous source-drain diode current	I _S	MOSFET sym		-	-	6.6	- A
Pulsed diode forward current ^a	I _{SM}	integral reverse p - n junction diode		-	-	44	
Body diode voltage	V _{SD}	T _J = 25 °C, I _S = 11 A, V _{GS} = 0 V ^b		-	-	1.5	V
Body diode reverse recovery time	t _{rr}	0 10 10		-	510	770	ns
Body diode reverse recovery charge	Q _{rr}	$ T_J = 25 ^{\circ}\text{C}$, $I_F = 11 \text{A}$, $dI/dt = 100 \text{A/}\mu\text{s}^{\text{b},\text{d}}$		-	3.4	5.1	μC
Forward turn-on time	t _{on}	Intrinsic tu	urn-on time is negligible (turn	on is dor	ninated b	y L _S and	L _D)

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %
- c. C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS}
- d. Uses IRFB11N50A, SiHFB11N50A data and test conditions



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

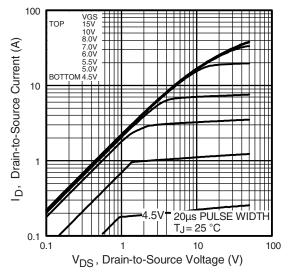


Fig. 1 - Typical Output Characteristics

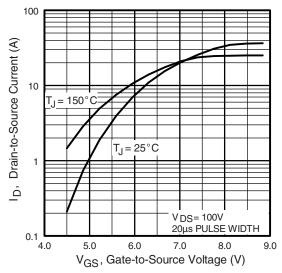


Fig. 3 - Typical Transfer Characteristics

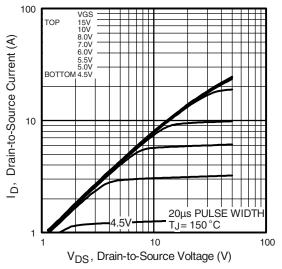


Fig. 2 - Typical Output Characteristics

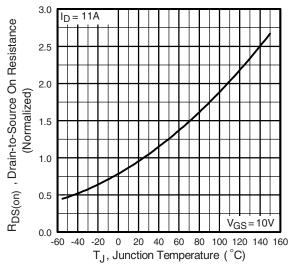


Fig. 4 - Normalized On-Resistance vs. Temperature



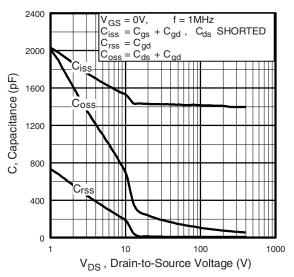


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

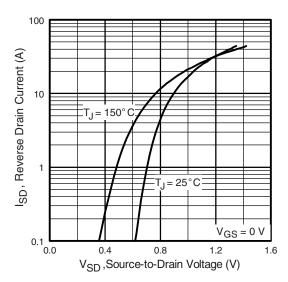


Fig. 7 - Typical Source-Drain Diode Forward Voltage

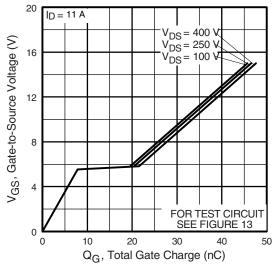


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

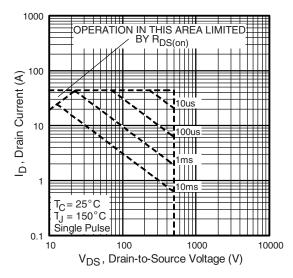


Fig. 8 - Maximum Safe Operating Area



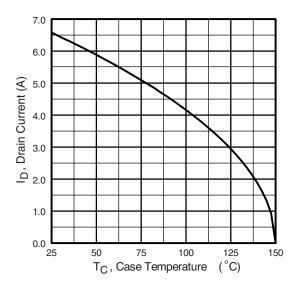


Fig. 9 - Maximum Drain Current vs. Case Temperature

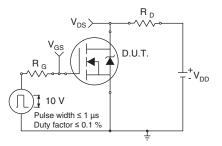


Fig. 10a - Switching Time Test Circuit

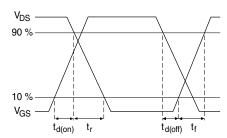


Fig. 10b - Switching Time Waveforms

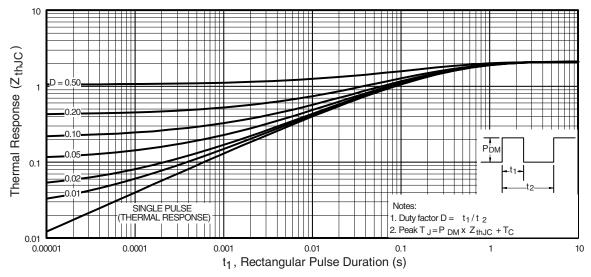


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

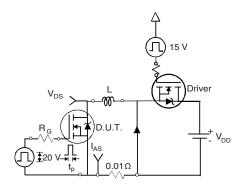


Fig. 12a - Unclamped Inductive Test Circuit

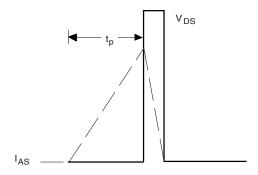


Fig. 12b - Unclamped Inductive Waveforms

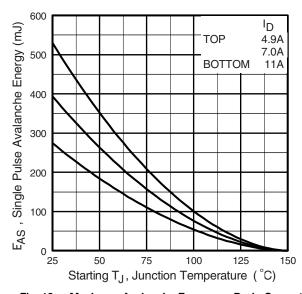


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

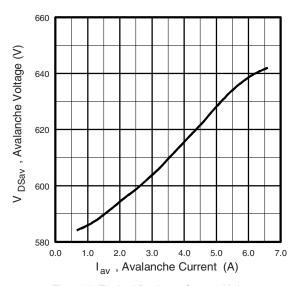


Fig. 12d -Typical Drain-to-Source Voltage vs.
Avalanche Current

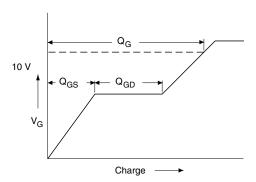


Fig. 13a - Basic Gate Charge Waveform

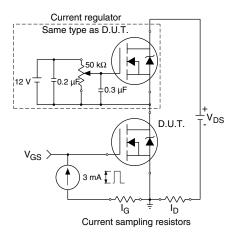
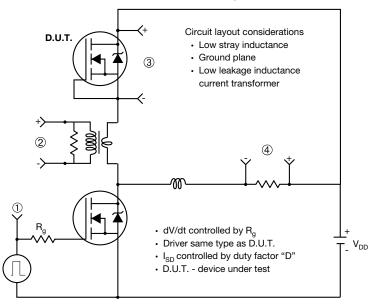


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



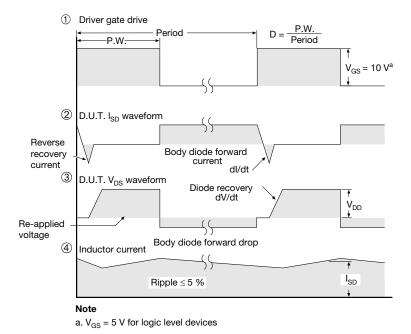


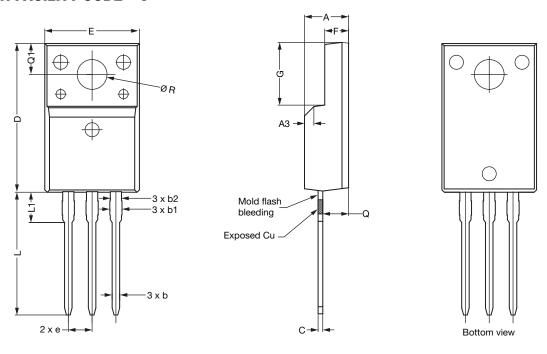
Fig. 14 - For N-Channel

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TO-220 FULLPAK (High Voltage)

OPTION 1: FACILITY CODE = 9

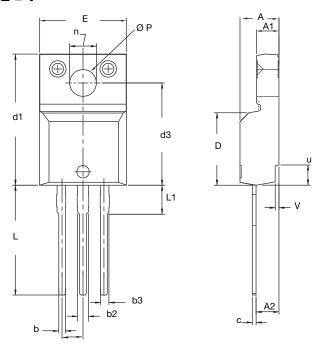


		MILLIMETERS	
DIM.	MIN.	NOM.	MAX.
Α	4.60	4.70	4.80
b	0.70	0.80	0.91
b1	1.20	1.30	1.47
b2	1.10	1.20	1.30
С	0.45	0.50	0.63
D	15.80	15.87	15.97
е		2.54 BSC	
E	10.00	10.10	10.30
F	2.44	2.54	2.64
G	6.50	6.70	6.90
L	12.90	13.10	13.30
L1	3.13	3.23	3.33
Q	2.65	2.75	2.85
Q1	3.20	3.30	3.40
ØR	3.08	3.18	3.28

- 1. To be used only for process drawing
- 2. These dimensions apply to all TO-220 FULLPAK leadframe versions 3 leads
- 3. All critical dimensions should C meet $C_{pk} > 1.33$
- 4. All dimensions include burrs and plating thickness
- 5. No chipping or package damage
- 6. Facility code will be the 1st character located at the 2nd row of the unit marking



OPTION 2: FACILITY CODE = Y



	MILLIMETERS		INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	4.570	4.830	0.180	0.190	
A1	2.570	2.830	0.101	0.111	
A2	2.510	2.850	0.099	0.112	
b	0.622	0.890	0.024	0.035	
b2	1.229	1.400	0.048	0.055	
b3	1.229	1.400	0.048	0.055	
С	0.440	0.629	0.017	0.025	
D	8.650	9.800	0.341	0.386	
d1	15.88	16.120	0.622	0.635	
d3	12.300	12.920	0.484	0.509	
Е	10.360	10.630	0.408	0.419	
е	2.54	2.54 BSC		0.100 BSC	
L	13.200	13.730	0.520	0.541	
L1	3.100	3.500	0.122	0.138	
n	6.050	6.150	0.238	0.242	
ØΡ	3.050	3.450	0.120	0.136	
u	2.400	2.500	0.094	0.098	
V	0.400	0.500	0.016	0.020	

ECN: E19-0180-Rev. D, 08-Apr-2019

DWG: 5972

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- 2. These dimensions apply to all TO-220 FULLPAK leadframe versions 3 leads
- 3. All critical dimensions should C meet $C_{pk} > 1.33$
- 4. All dimensions include burrs and plating thickness
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